

Application/Control f	No. Applicant(s)/Patent ι Reexamination	ınder
10/815,314	FUKUSHIMA ET AL	
Examiner	Art Unit	
Jason C. Olson	2651	

	SEAR	CHED	
Class	Subclass	Date	Examiner
NONE			
			. :

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
US-PGPUI See Sear		7/20/2005	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
PLUS Search - See Search History Printout	7/20/2005		
East Text Search (US-PGPUB, USPAT, EPO, JPO, DERWENT, IBM_IDB) – See Search History Printout	7/20/2005		
Inventorship Search - See Search History Printout	7/20/2005		
	:		